

N-Channel 200 V (D-S) MOSFET

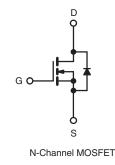
| PRODUCT SUMMARY | | | | | | |
|----------------------------|------------------------|-------|--|--|--|--|
| V _{DS} (V) | 200 | | | | | |
| R _{DS(on)} (Ω) | V _{GS} = 10 V | 0.265 | | | | |
| Q _g (Max.) (nC) | 16 | | | | | |
| Q _{gs} (nC) | 5 | | | | | |
| Q _{gd} (nC) | 8 | | | | | |
| Configuration | Single | | | | | |

FEATURES

- · Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- · Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available







| ABSOLUTE MAXIMUM RATINGS T | _C = 25 °C, unl | ess otherw | ise noted | | | |
|--|---------------------------|---|-----------------------------------|------------------|----------|--|
| PARAMETER | | | SYMBOL | LIMIT | UNIT | |
| Drain-Source Voltage | | | V _{DS} | 200 | v | |
| Gate-Source Voltage | | | V _{GS} | ± 20 | | |
| Continuous Drain Current | V _{GS} at 10 V | $T_C = 25 \degree C$ $T_C = 100 \degree C$ | - I _D - | 10 | | |
| | VGS AL TO V | T _C = 100 °C | | 6.5 | A | |
| Pulsed Drain Current ^a | | | I _{DM} | 32 | | |
| Linear Derating Factor | | | | 0.24 | W/°C | |
| Single Pulse Avalanche Energy ^b | | | E _{AS} | 36 | mJ | |
| Repetitive Avalanche Current ^a | | | I _{AR} | 7.2 | A | |
| Repetitive Avalanche Energy ^a | | | E _{AR} | 3.7 | mJ | |
| Maximum Power Dissipation | T _C = 25 °C | | PD | 37 | W | |
| Peak Diode Recovery dV/dt ^c | | | dV/dt | 5.5 | V/ns | |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | - 55 to + 175 | °C | |
| Soldering Recommendations (Peak Temperature) | for 10 s | | | 300 ^d | | |
| Mounting Torque | 6-32 or M3 screw | | | 10 | lbf ⋅ in | |
| Mounting rorque | | | | 1.1 | N · m | |

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 1.0 mH, $R_G = 25 \Omega$, $I_{AS} = 7.2 \text{ A}$ (see fig. 12). c. $I_{SD} \le 9.2 \text{ A}$, dl/dt $\le 110 \text{ A/}\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_J \le 175 \text{ °C}$.

d. 1.6 mm from case.



| THERMAL RESISTANCE RA | TINGS | | | | | | | | |
|--|-----------------------|--|--|--------------------------|------|-------|-------|------|--|
| PARAMETER | SYMBOL | TYP. | | MAX. | | UNIT | | | |
| Maximum Junction-to-Ambient | R _{thJA} | - 65 | | | | | | | |
| Maximum Junction-to-Case (Drain) | R _{thJC} | - 4.1 | | | | °C/W | | | |
| | | | | | | | | | |
| SPECIFICATIONS $T_J = 25 \ ^{\circ}C$, | unless otherw | vise noted | | | - | - | | | |
| PARAMETER | SYMBOL | TES | T CONDITI | ONS | MIN. | TYP. | MAX. | UNIT | |
| Static | | | | | | | | | |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} = | 0 V, I _D = 2 | 50 μΑ | 200 | - | - | V | |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | Reference | e to 25 °C, | I _D = 1 mA | - | 0.13 | - | V/°C | |
| Gate-Source Threshold Voltage | V _{GS(th)} | V _{DS} = | $V_{GS}, I_D = 2$ | 250 μΑ | 2.0 | - | 4.0 | V | |
| Gate-Source Leakage | I _{GSS} | l v | $I_{\rm GS} = \pm 20$ | V | - | - | ± 100 | nA | |
| Zero Gate Voltage Drain Current | | V _{DS} = | $V_{DS} = 200 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$ | | | - | 25 | μΑ | |
| | IDSS | V _{DS} =160 V, V _{GS} = 0 V, T _J = 150 °C | | | - | - | 250 | | |
| Drain-Source On-State Resistance | R _{DS(on)} | V _{GS} = 10 V | I _D | = 4.3 A ^b | - | 0.265 | - | Ω | |
| Forward Transconductance | 9 _{fs} | $V_{DS} = 50 \text{ V}, \text{ I}_{D} = 4.3 \text{ A}^{b}$ | | 2.3 | - | - | S | | |
| Dynamic | | | | | | | | | |
| Input Capacitance | C _{iss} | | | - | 560 | - | | | |
| Output Capacitance | C _{oss} | , | V _{GS} = 0 V, V _{DS} = 25 V, | | - | 260 | - | 1 _ | |
| Reverse Transfer Capacitance | C _{rss} | f = 1.0 MHz, see fig. 5 f = 1.0 MHz | | - | 110 | - | pF | | |
| Drain to Sink Capacitance | С | | | - | 12 | - | | | |
| Total Gate Charge | Qg | | | | - | - | 16 | | |
| Gate-Source Charge | Q _{gs} | V _{GS} = 10 V | $V_{GS} = 10 \text{ V}$ $I_D = 9.2 \text{ A},$ | | - | - | 4.4 | nC | |
| Gate-Drain Charge | Q _{gd} | | 366 H | g. 6 and 13 ^b | - | - | 7.7 | | |
| Turn-On Delay Time | t _{d(on)} | • | | | - | 8.8 | - | | |
| Rise Time | t _r | $\begin{array}{l} {\sf V}_{{\sf D}{\sf D}}\ =\ 100\ {\sf V},\ {\sf I}_{{\sf D}}\ =\ 9.2\ {\sf A},\\ {\sf R}_{{\sf G}}\ =\ 18\ \Omega,\ {\sf R}_{{\sf D}}\ =\ 5.2\ \Omega,\\ {\sf see\ fig.\ 10^b} \end{array}$ | | - | 30 | - | ns | | |
| Turn-Off Delay Time | t _{d(off)} | | | - | 19 | - | | | |
| Fall Time | t _f | | | - | 20 | - | | | |
| Internal Drain Inductance | L _D | Between lead, 6 mm (0.25") from package and center of die contact | | - | 4.5 | - | nH | | |
| Internal Source Inductance | L _S | | | - | 7.5 | - | | | |
| Drain-Source Body Diode Characteristic | cs | | | | | | | | |
| Continuous Source-Drain Diode Current | I _S | MOSFET symbol showing the | | - | 10 | - | A | | |
| Pulsed Diode Forward Current ^a | I _{SM} | integral reverse p - n junction diode | | | - | 32 | | - | |
| Body Diode Voltage | V _{SD} | T _J = 25 °C, | $T_{J} = 25 \text{ °C}, I_{S} = 7.2 \text{ A}, V_{GS} = 0 \text{ V}^{b}$ | | - | - | 2.5 | V | |
| Body Diode Reverse Recovery Time | t _{rr} | $T_{J} = 25 \text{ °C}, I_{F} = 9.2 \text{ A}, dI/dt = 100 \text{ A}/\mu s^{b}$ | | - | 130 | 260 | ns | | |
| Body Diode Reverse Recovery Charge | Q _{rr} | | | - | 0.65 | 1.3 | μC | | |
| Forward Turn-On Time | t _{on} | Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D) | | | | | | | |

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %.





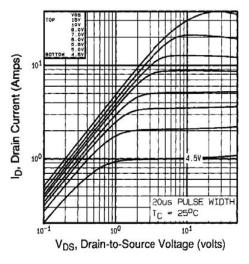


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

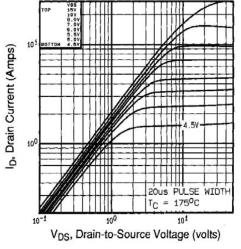


Fig. 2 - Typical Output Characteristics, T_C = 175 $^\circ C$

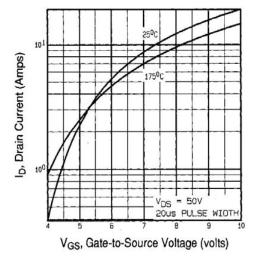


Fig. 3 - Typical Transfer Characteristics

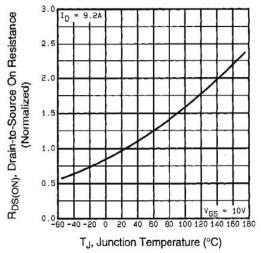


Fig. 4 - Normalized On-Resistance vs. Temperature

IRFI610GPBF



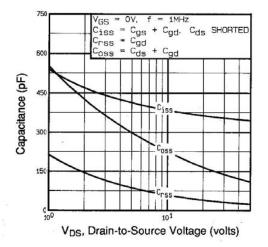


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

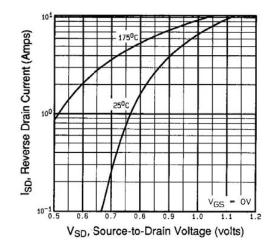


Fig. 7 - Typical Source-Drain Diode Forward Voltage

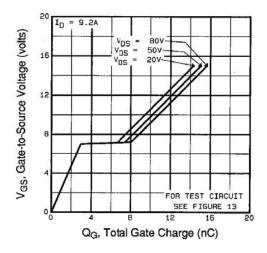


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

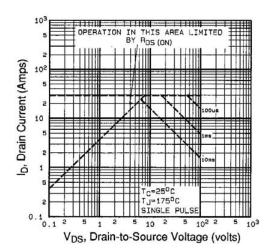


Fig. 5 - Fig. 8 - Maximum Safe Operating Area

IRFI610GPBF



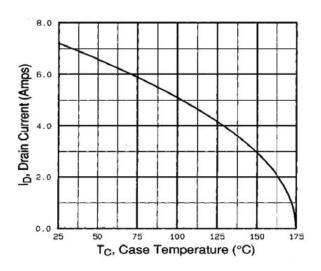


Fig. 9 - Maximum Drain Current vs. Case Temperature

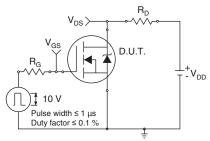


Fig. 10a - Switching Time Test Circuit

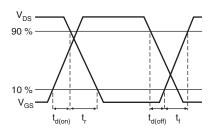
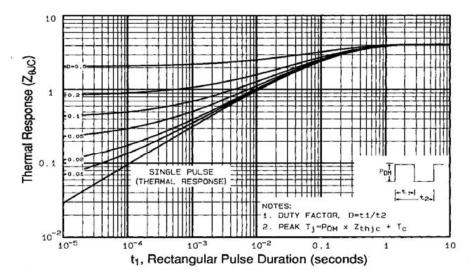


Fig. 10b - Switching Time Waveforms





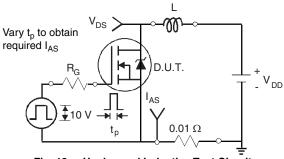


Fig. 12a - Unclamped Inductive Test Circuit

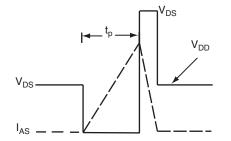
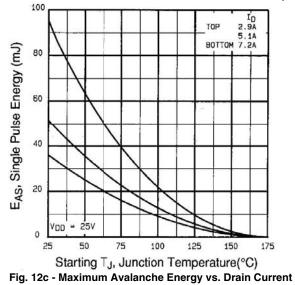


Fig. 12b - Unclamped Inductive Waveforms







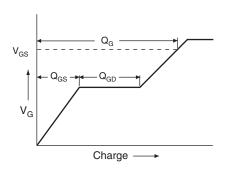
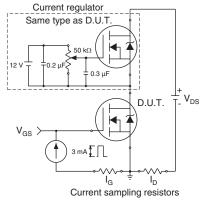
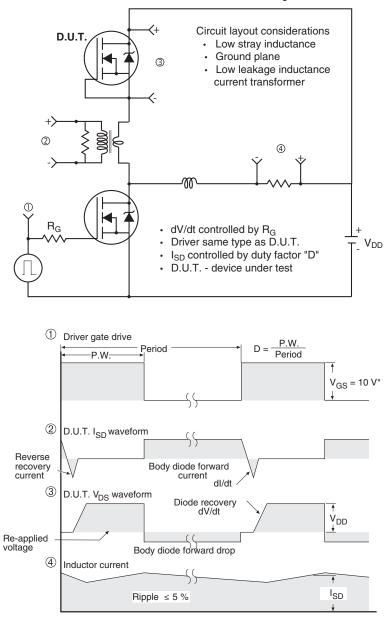


Fig. 13a - Basic Gate Charge Waveform









Peak Diode Recovery dV/dt Test Circuit

* V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel



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